

### **Power MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	250				
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V	0.64			
Q <sub>g</sub> (Max.) (nC)	14				
Q <sub>gs</sub> (nC)	2.7				
Q <sub>gd</sub> (nC)	7.8				
Configuration	Single				

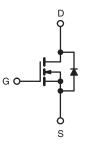
#### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Available in Tape and Reel
- Fast Switching
- Ease of Paralleling



**DPAK** (TO-252)





N-Channel MOSFET

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V <sub>DS</sub>	250	V	
Gate-Source Voltage			V <sub>GS</sub>	± 20	V	
Continuous Drain Current	$V_{GS}$ at 10 V $T_{C} = 25 ^{\circ}C$ $T_{C} = 100 ^{\circ}C$		,	4.5		
Continuous Drain Current	$T_{C} = T_{C}$	<sub>C</sub> = 100 °C	I <sub>D</sub>	3.0	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	16		
Linear Derating Factor				0.33	W/°C	
Linear Derating Factor (PCB Mount)e				0.020	] W/C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	130	mJ	
Repetitive Avalanche Currenta			I <sub>AR</sub>	4.5	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	5.2	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C			45	W	
Maximum Power Dissipation (PCB Mount) <sup>e</sup>	T <sub>A</sub> = 25 °C		$P_{D}$	2.5	] vv	
Peak Diode Recovery dV/dtc			dV/dt	4.8	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) <sup>d</sup> for 10 s			260			

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD} = 50 \text{ V}$ ; starting  $T_J = 25 \text{ °C}$ , L = 14 mH,  $R_g = 25 \Omega$ ,  $I_{AS} = 3.8 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 3.8 \text{ A}$ ,  $dI/dt \le 90 \text{ A/µs}$ ,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150 \text{ °C}$ .
- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material) .



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub>	-	50			
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	110	°C/W		
Maximum Junction-to-Case	$R_{thJC}$	-	3.0			

#### Note

a. When mounted on 1" square PCB ( FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		·					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> :	= 0 V, I <sub>D</sub> = 250 μA	250	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I <sub>D</sub> = 1 mA	-	0.36	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>		V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zoro Coto Voltago Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 250 V, V <sub>GS</sub> = 0 V		-	-	25	μΑ
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 200 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	-	250	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	$I_D = 2.3 A^b$	-	0.64	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	= 50 V, I <sub>D</sub> = 2.3 A <sup>b</sup>	1.5	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,	-	260	-	
Output Capacitance	Coss	]	$V_{DS} = 25 \text{ V},$	-	77	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.	0 MHz, see fig. 5 <sup>c</sup>	-	15	-	
Total Gate Charge	Qg				-	14	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$I_D = 4.4 \text{ A}, V_{DS} = 200 \text{ V},$ see fig. 6 and $13^{b, c}$	-	-	2.7	nC
Gate-Drain Charge	Q <sub>gd</sub>	1	g. o and ro	-	-	7.8	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = 125 V, $I_{D}$ = 4.4 A, $R_{G}$ = 18 $\Omega$ , $R_{D}$ = 28 $\Omega$ , see fig. 10 <sup>b, c</sup>		-	7.0	-	- ns
Rise Time	t <sub>r</sub>			-	13	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	20	-	
Fall Time	t <sub>f</sub>			-	12	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s	•					
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	3.8	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	15	
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 3.8 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	- T <sub>J</sub> = 25 °C, I <sub>F</sub> = 4.4 A, dl/dt = 100 A/μs <sup>b</sup>		-	200	400	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.93	1.9	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	-on is dor	ninated b	y L <sub>S</sub> and	L <sub>D</sub> )	

- Notes a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

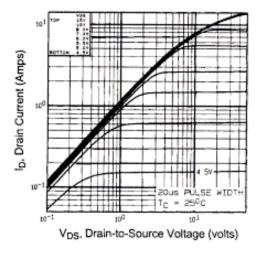


Fig. 1 - Typical Output Characteristics,  $T_C$  = 25 °C

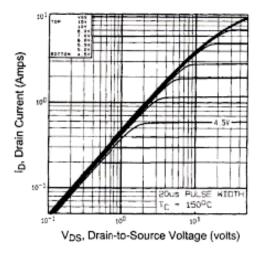


Fig. 2 - Typical Output Characteristics,  $T_C$  = 150 °C

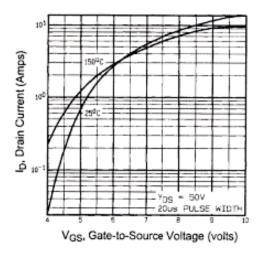


Fig. 3 - Typical Transfer Characteristics

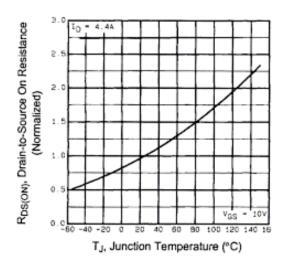


Fig. 4 - Normalized On-Resistance vs. Temperature



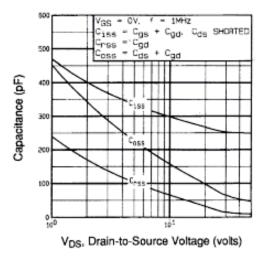


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

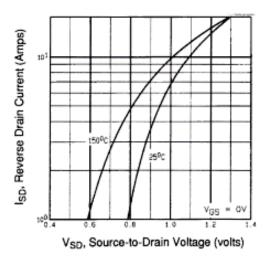


Fig. 7 - Typical Source-Drain Diode Forward Voltage

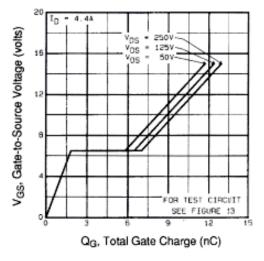


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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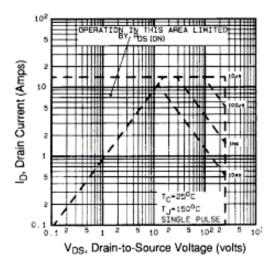


Fig. 8 - Maximum Safe Operating Area



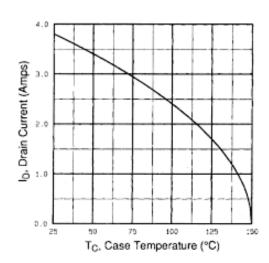


Fig. 9 - Maximum Drain Current vs. Case Temperature

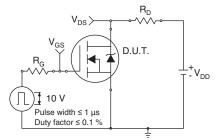


Fig. 10a - Switching Time Test Circuit

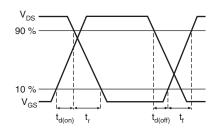


Fig. 10b - Switching Time Waveforms

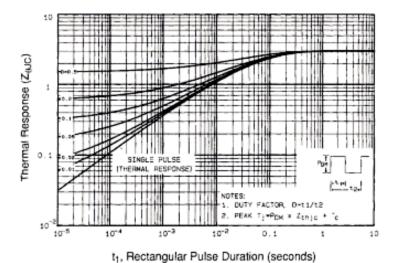
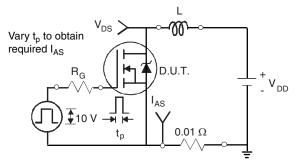
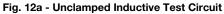


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case







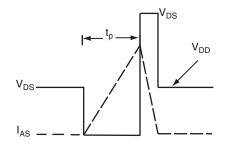


Fig. 12b - Unclamped Inductive Waveforms

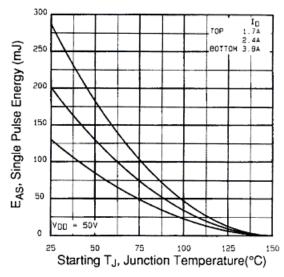


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

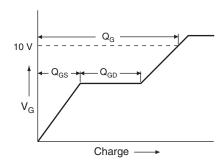


Fig. 13a - Basic Gate Charge Waveform

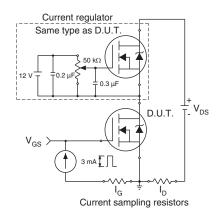
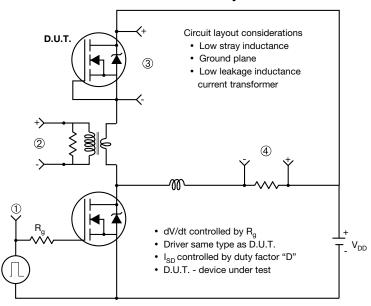


Fig. 13b - Gate Charge Test Circuit



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#### Peak Diode Recovery dV/dt Test Circuit



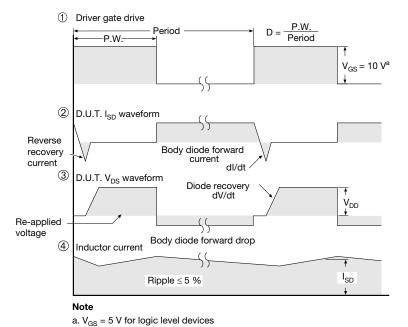
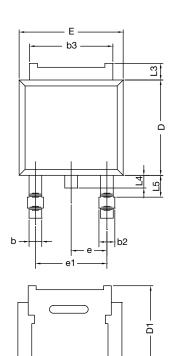
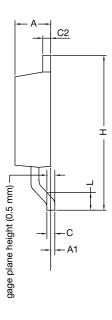


Fig. 14 - For N-Channel



# **TO-252AA Case Outline**





	MILLIN	METERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	4.10	-	0.161	-	
Е	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28	BSC	0.090 BSC		
e1	4.56 BSC		0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.01	1.52	0.040	0.060	
ECNI: T16	0006 Dov D	16 May 16	-		

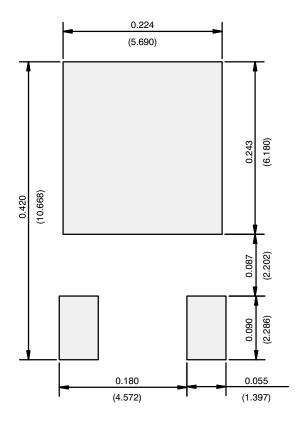
ECN: T16-0236-Rev. P, 16-May-16 DWG: 5347

#### Notes

• Dimension L3 is for reference only.



### **RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)**



Recommended Minimum Pads Dimensions in Inches/(mm)



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